

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/764,302	TSUCHIMURA ET AL.
Examiner	Art Unit	
Le Nguyen	2174	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
US-PPGPUB; USPAT: 715/788,792		6/23/2006	LVN